SN54LVC373A供应商

SN54LVC373A, SN74LVC373A OCTAL TRANSPARENT D-TYPE LATCHES WITH 3-STATE OUTPUTS

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- *EPIC*[™] (Enhanced-Performance Implanted CMOS) Submicron Process
- Typical V_{OLP} (Output Ground Bounce) < 0.8 V at V_{CC} = 3.3 V, $T_A = 25^{\circ}C$
- Typical V_{OHV} (Output V_{OH} Undershoot)
 > 2 V at V_{CC} = 3.3 V, T_A = 25°C
- Power Off Disables Outputs, Permitting Live Insertion
- Support Mixed-Mode Signal Operation on All Ports (5-V Input/Output Voltage With 3.3-V V_{CC})
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- Package Options Include Plastic Small-Outline (DW), Shrink Small-Outline (DB), and Thin Shrink Small-Outline (PW) Packages, Ceramic Chip Carriers (FK), Ceramic Flat (W) Packages, and DIPs (J)

description

The SN54LVC373A octal transparent D-type latch is designed for 2.7-V to 3.6-V V_{CC} operation and the SN74LVC373A octal transparent D-type latch is designed for 1.65-V to 3.6-V V_{CC} operation.

While the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs. When LE is taken low, the Q outputs are latched at the logic levels set up at the D inputs.

A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low logic levels) or a high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

OE does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of these devices as translators in a mixed 3.3-V/5-V system environment.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

The SN54LVC373A is characterized for operation over the full military temperature range of -55° C to 125° C. The SN74LVC373A is characterized for operation from -40° C to 85° C.



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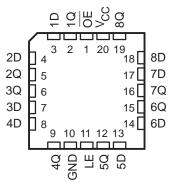


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SN54LVC373A J OR W PACKAGE
SN74LVC373A DB, DW, OR PW PACKAGE

	(10)	VIEW)	
OE	1	\cup_{20}	Vcc
1Q	2	19] 8Q
1D	3	18] 8D
2D	4	17]7D
2Q	5	16] 7Q
3Q	6	15] 6Q
3D	7	14] 6D
4D	8	13] 5D
4Q	9	12] 5Q
GND	10	11	LE
			,

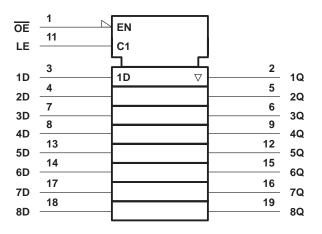
SN54LVC373A . . . FK PACKAGE (TOP VIEW)



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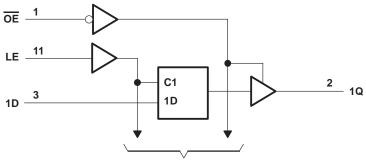
	FUNCTION TABLE (each latch)										
	INPUTS OUTPUT										
OE	LE	Q									
L	Н	Н	Н								
L	Н	L	L								
L	L	Х	Q ₀								
Н	Х	Х	Z								

logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagram (positive logic)



To Seven Other Channels



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range, V _{CC} Input voltage range, V _I (see Note 1)	
Voltage range applied to any output in the high-impedance or power-off state, V _O (see Note 1)	–0.5 V to 6.5 V
Voltage range applied to any output in the high or low state, V_{O}	
(see Notes 1 and 2)	–0.5 V to V _{CC} + 0.5 V
Input clamp current, I _{IK} (V _I < 0)	–50 mA
Output clamp current, I _{OK} (V _O < 0)	–50 mA
Continuous output current, I _O	±50 mA
Continuous current through V _{CC} or GND	±100 mA
Package thermal impedance, θ_{JA} (see Note 3): DB package	115°C/W
DW package	97°C/W
PW package	128°C/W
Storage temperature range, T _{stg}	\ldots

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The value of V_{CC} is provided in the recommended operating conditions table.

3. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions (see Note 4)

			SN54L	VC373A	SN74L	/C373A	UNIT
			MIN	MAX	MIN	MAX	UNIT
\/	Cumple weltere	Operating	2	3.6	1.65	3.6	V
VCC	Supply voltage	Data retention only	1.5		1.5		V
		V _{CC} = 1.65 V to 1.95 V			$0.65 \times V_{CC}$		
VIH	High-level input voltage	V_{CC} = 2.3 V to 2.7 V			1.7		V
		V _{CC} = 2.7 V to 3.6 V	2		2		
		V _{CC} = 1.65 V to 1.95 V				$0.35 \times V_{CC}$	
VIL	Low-level input voltage	V _{CC} = 2.3 V to 2.7 V				0.7	V
		V _{CC} = 2.7 V to 3.6 V		0.8		0.8	
VI	Input voltage		0	5.5	0	5.5	V
\/_	Outrast unlike an	High or low state	0	VCC	0	VCC	V
VO	Output voltage	3 state	0	5.5	0	5.5	V
		V _{CC} = 1.65 V				-4	
1	Lich lovel output output	V _{CC} = 2.3 V				-8	A
ЮН	High-level output current	V _{CC} = 2.7 V		-12		-12	mA
		$V_{CC} = 3 V$		-24		-24	
		V _{CC} = 1.65 V				4	
IOL		V _{CC} = 2.3 V				8	
	Low-level output current	V _{CC} = 2.7 V		12		12	mA
		$V_{CC} = 3 V$		24		24	
$\Delta t/\Delta v$	Input transition rise or fall rate		0	10	0	10	ns/V
Тд	Operating free-air temperature		-55	125	-40	85	°C

NOTE 4: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.



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electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDIT	IONE	vcc	SN54	LVC373	A	SN74	LVC373	A	UNI
PARAMETER	TEST CONDIT			MIN	TYP†	MAX	MIN	TYP [†]	MAX	UNI
	100.04		1.65 V to 3.6 V				V _{CC} -0.2			
	I _{OH} = -100 μA		2.7 V to 3.6 V	V _{CC} -0.2						
	I _{OH} = -4 mA		1.65 V				1.2			
Vон	I _{OH} = -8 mA		2.3 V				1.7			V
	1011 - 12 mA		2.7 V	2.2			2.2			
	I _{OH} = -12 mA		3 V	2.4			2.4			
	I _{OH} = -24 mA		3 V	2.2			2.2			
	le 100		1.65 V to 3.6 V						0.2	
	I _{OL} = 100 μA		2.7 V to 3.6 V			0.2				7 V
Ve	I _{OL} = 4 mA I _{OL} = 8 mA I _{OL} = 12 mA		1.65 V						0.45	
VOL			2.3 V						0.7	
			2.7 V			0.4			0.4	
	I _{OL} = 24 mA		3 V			0.55			0.55	
lj	V _I = 0 to 5.5 V		3.6 V			±5			±5	μA
loff	$V_{I} \text{ or } V_{O} = 5.5 \text{ V}$		0						±10	μA
I _{OZ}	V _O = 0 to 5.5 V		3.6 V			±15			±10	μA
	$V_I = V_{CC}$ or GND		0.01/			10			10	
ICC	$3.6 \text{ V} \leq \text{V}_{I} \leq 5.5 \text{ V}^{\ddagger}$	IO = 0	3.6 V			10			10	μA
ΔICC	One input at $V_{CC} - 0$. Other inputs at V_{CC} o		2.7 V to 3.6 V			500			500	μA
Ci	$V_{I} = V_{CC} \text{ or } GND$		3.3 V		4	12		4		pF
Co	$V_{O} = V_{CC}$ or GND		3.3 V		5.5	12		5.5		pF

[†] All typical values are at $V_{CC} = 3.3 \text{ V}$, $T_A = 25^{\circ}\text{C}$.

[‡] This applies in the disabled state only.

timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

			SN54L\	/C373A		
				V _{CC} = 3.3 V ± 0.3 V		UNIT
		MIN	MAX	MIN	MAX	
tw	Pulse duration, LE high	3.3		3.3		ns
t _{su}	Setup time, data before LE \downarrow	2		2		ns
t _h	Hold time, data after LE \downarrow	2		2		ns



timing requirements over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

	SN74LVC373A									
			1.8 V 5 V	V _{CC} = ± 0.		V _{CC} =	2.7 V	V _{CC} = ± 0.3	3.3 V 3 V	UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
tw	Pulse duration, LE high	†		†		3.3		3.3		ns
t _{su}	Setup time, data before LE \downarrow	†		†		2		2		ns
t _h	Hold time, data after LE \downarrow	†		†		1.5		1.5		ns

[†] This information was not available at the time of publication.

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figure 3)

PARAMETER			SN54	LVC3	73A		
	FROM (INPUT)	TO (OUTPUT)	V _{CC} = 2.7 V	V	CC = ± 0.3	3.3 V 3 V	UNIT
			MIN MA	X I	MIN	MAX	
÷ .	D	Q	8.	5	1	7.5	ns
^t pd	LE	Q	9.	5	1	8.5	115
t _{en}	OE	Q	8.	7	1	7.7	ns
^t dis	OE	Q		8	0.5	7	ns

switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 through 3)

						SN74L\	/C373A				
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V _{CC} = ± 0.1		V _{CC} = ± 0.2	2.5 V 2 V	V _{CC} =	2.7 V	= ۷ _{CC} ± 0.:	3.3 V 3 V	UNIT
			MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
÷ .	D	Q	†	†	†	†		7.8	1.5	6.8	ns
^t pd	LE		†	†	†	†		8.2	2	7.6	115
t _{en}	OE	Q	†	†	†	†		8.7	1.5	7.7	ns
^t dis	OE	Q	†	†	†	†		7.6	1.5	7	ns
^t sk(o) [‡]										1	ns

[†] This information was not available at the time of publication.

[‡] Skew between any two outputs of the same package switching in the same direction

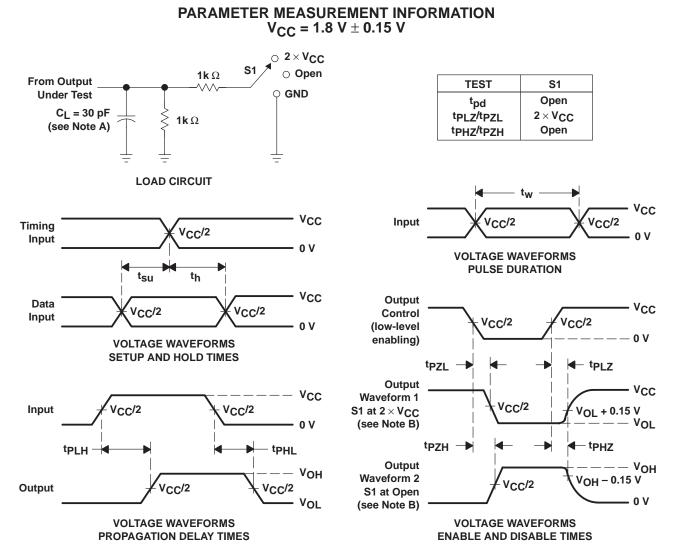
operating characteristics, T_A = 25°C

	PARAMETER			V _{CC} = 1.8 V ± 0.15 V	V _{CC} = 2.5 V ± 0.2 V	V _{CC} = 3.3 V ± 0.3 V	UNIT
			CONDITIONS	TYP	TYP	TYP	
Cpd	Power dissipation capacitance	Outputs enabled	f = 10 MHz	†	†	46	pF
Сра	per latch	Outputs disabled		†	†	3	ρr

[†] This information was not available at the time of publication.



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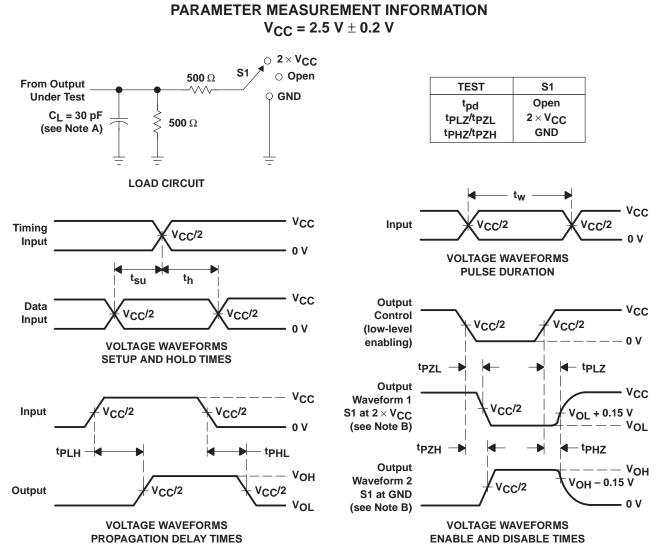
NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2 ns, t_f \leq 2 ns.
- D. The outputs are measured one at a time with one transition per measurement.
- Ε. t_{PI} and t_{PH7} are the same as t_{dis} .
- F. tpzL and tpzH are the same as ten.
- G. tPLH and tPHL are the same as tpd.





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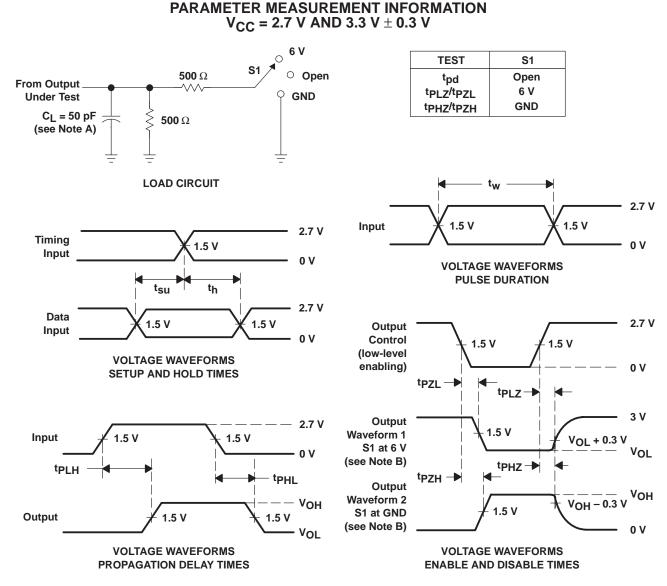


- NOTES: A. CI includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control. C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2 ns, t_f \leq 2 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. tPLZ and tPHZ are the same as tdis.
 - F. tpzL and tpzH are the same as ten.
 - G. tpl H and tpHI are the same as tpd.

Figure 2. Load Circuit and Voltage Waveforms



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- NOTES: A. CL includes probe and jig capacitance.
 - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
 - C. All input pulses are supplied by generators having the following characteristics: PRR \leq 10 MHz, Z_O = 50 Ω , t_f \leq 2.5 ns, t_f \leq 2.5 ns.
 - D. The outputs are measured one at a time with one transition per measurement.
 - E. t_{PI7} and t_{PH7} are the same as t_{dis} .
 - F. t_{PZL} and t_{PZH} are the same as t_{en} .
 - G. t_{PLH} and t_{PHL} are the same as t_{pd} .

Figure 3. Load Circuit and Voltage Waveforms



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